

Application/Control No.	Applicant(s)/Patent under Reexamination ALVAREZ-GOMARIZ ET AL.	
10/609,153		
Examiner	Art Unit	
Phallaka Kik	2825	

SEARCHED				
Class	Subclass	Date	Examiner	
716	5,21	11/10/2005	PK	
382	144,154	11/10/2005	PK	
382	203	11/10/2005	PK	
430	5	11/10/2005	PK	
378	35	11/10/2005	PK	
700	120,121	11/10/2005	PK	
250	492.22	11/10/2005	PK	
Above	updated	4/2/2006	PK	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
716	5,21	4/2/2006	PK		
382	144,154	4/2/2006	PK		
382	203	4/2/2006	PK		
USPGPUB (see attached)		4/2/2006	PK		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
BRS (EAST)USPAT, USPGPUB Cls/Sub searched: 716/1-21.; 382/144,154,203-204,212- 214,283; 430/4-5; 378/34-35 (see attached)	11/10/2005	PK
BRS (EAST) (Con't)USPAT, USPGPUB Cls/Sub searched: 700/120-121; 250/492.2-492.3 (see attached)	11/10/2005	PK
Above updated search (see attached)	4/2/2006	PK
IEE/IEEE XPlore (see attached)	11/10/2005	PK
EPO, JPO, IBM TDB, Derwent (see attached)	11/10/2005	PK